

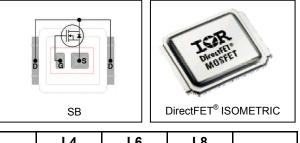
# AUIRF7665S2TR

Înfineon

- Advanced Process Technology
- Optimized for Class D Audio Amplifier Applications
- Low Rds(on) for Improved Efficiency
- Low Qg for Better THD and Improved Efficiency
- Low Qrr for Better THD and Lower EMI
- Low Parasitic Inductance for Reduced Ringing and Lower EMI
- Delivers up to 100W per Channel into  $8\Omega$  with No Heatsink
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead free, RoHS and Halogen free
- Automotive Qualified \*

100V
51mΩ
<b>62</b> mΩ
3.5Ω
8.3nC

Automotive DirectFET<sup>®</sup> Power MOSFET ②



## Applicable DirectFET<sup>®</sup> Outline and Substrate Outline ①

	SB	SC			M2	M4		L4	L6	L8	
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### Description

The AUIRF7665S2 combines the latest Automotive HEXFET<sup>®</sup> Power MOSFET Silicon technology with the advanced DirectFET<sup>®</sup> packaging platform to produce a best in class part for Automotive Class D audio amplifier applications. The DirectFET<sup>®</sup> package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET<sup>®</sup> package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET<sup>®</sup> Power MOSFET optimizes gate charge, body diode reverse recovery and internal gate resistance to improve key Class D audio amplifier performance factors such as efficiency, THD and EMI. Moreover the DirectFET<sup>®</sup> packaging platform offers low parasitic inductance and resistance when compared to conventional wire bonded SOIC packages which improves EMI performance by reducing the voltage ringing that accompanies current transients.

These features combine to make this MOSFET a highly desirable component in Automotive Class D audio amplifier systems.

ĺ	Base Part Number	Baakaga Typa	Standard	Orderable Part Number	
	Dase Part Number	Package Type	Form	Quantity	Orderable Fart Nulliber
	AUIRF7665S2	DirectFET Small Can	Tape and Reel	4800	AUIRF7665S2TR

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units	
V <sub>DS</sub>	Drain-to-Source Voltage	100	V	
V <sub>GS</sub>	Gate-to-Source Voltage	±20	v	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) ④	14.4		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) ④	10.2		
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) ③	4.1	А	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	77		
I <sub>DM</sub>	Pulsed Drain Current ©	58		
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation ④	30	W	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation ③	2.4	vv	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 6	37		
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy 6	56	mJ	
I <sub>AR</sub>	Avalanche Current ©	Cap Fig. 16, 17, 19a, 19b	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy ©	See Fig. 16, 17, 18a, 18b	mJ	
Τ <sub>Ρ</sub>	Peak Soldering Temperature	270		
TJ	Operating Junction and	-55 to + 175	°C	
T <sub>STG</sub>	Storage Temperature Range			

HEXFET® is a registered trademark of Infineon.

\*Qualification standards can be found at www.infineon.com

## **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JA}$	Junction-to-Ambient ③		63	
$R_{ ext{ heta}JA}$	Junction-to-Ambient ®	12.5		
$R_{ ext{ heta}JA}$	Junction-to-Ambient	20		°C/W
$R_{ ext{ hetaJ-Can}}$	Junction-to-Can ④ ⑩		5.0	
$R_{\theta J ext{-PCB}}$	PCB Junction-to-PCB Mounted 1.4 —			
	Linear Derating Factor ④ 0.2			W/°C

## Static Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	100			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.10		V/°C	Reference to $25^{\circ}$ C, I <sub>D</sub> = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		51	62	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 8.9A ⊘
V <sub>GS(th)</sub>	Gate Threshold Voltage	3.0	4.0	5.0	V	
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Coefficient		-13		mV/°C	$V_{DS} = V_{GS}, I_D = 25 \mu A$
gfs	Forward Transconductance	8.8	_		S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 8.9A
R <sub>G</sub>	Internal Gate Resistance		3.5	5.0	Ω	
	Drain to Source Lookage Current			5.0		V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS}$ = 80V, $V_{GS}$ = 0V, $T_{J}$ = 125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	<b>n</b> A	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

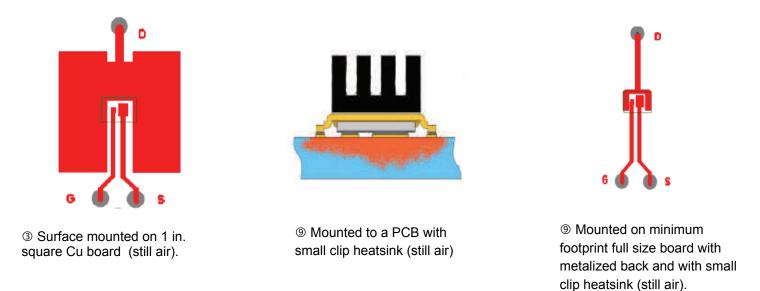
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		8.3	13		V <sub>DS</sub> = 50V
Q <sub>gs1</sub>	Gate-to-Source Charge		1.9			V <sub>GS</sub> = 10V
Q <sub>gs2</sub>	Gate-to-Source Charge		0.77			I <sub>D</sub> = 8.9A
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		3.2		nC	See Fig. 11
Q <sub>godr</sub>	Gate Charge Overdrive		2.4			
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		4.0			
Q <sub>oss</sub>	Output Charge		4.7		nC	V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V
t <sub>d(on)</sub>	Turn-On Delay Time		3.8			V <sub>DD</sub> = 50V
t <sub>r</sub>	Rise Time		6.4			I <sub>D</sub> = 8.9A
t <sub>d(off)</sub>	Turn-Off Delay Time		7.1		ns	$R_{G} = 6.8\Omega$
t <sub>f</sub>	Fall Time		3.6			V <sub>GS</sub> = 10V ⑦
C <sub>iss</sub>	Input Capacitance		515			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		110			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		30			f = 1.0 MHz
C <sub>oss</sub>	Output Capacitance		530		pF	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0 \text{ MHz}$
C <sub>oss</sub>	Output Capacitance		70			$V_{GS} = 0V, V_{DS} = 80V, f = 1.0 \text{ MHz}$
C <sub>oss</sub>	Output Capacitance		115			$V_{GS} = 0V, V_{DS} = 0 \text{ to } 80V$

# Notes ${\rm \textcircled{O}}$ through ${\rm \textcircled{O}}$ are on page 3



## **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			111		MOSFET symbol
IS	(Body Diode)			14.4	^	showing the
1	Pulsed Source Current			50	A	integral reverse
I <sub>SM</sub>	(Body Diode) ⑤			58	00	p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$T_J$ = 25°C, $I_S$ = 8.9A, $V_{GS}$ = 0V $\odot$
trr	Reverse Recovery Time		33		ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 8.9A, V <sub>DD</sub> = 25V
Q <sub>rr</sub>	Reverse Recovery Charge		38		nC	dv/dt = 100A/µs ⊘



- 0 Click on this section to link to the appropriate technical paper. 0 Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④ T<sub>c</sub> measured with thermocouple mounted to top (Drain) of part.
- © Repetitive rating; pulse width limited by max. junction temperature.
- 6 Starting T<sub>J</sub> = 25°C, L = 0.944mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 8.9A.
- $\bigcirc$  Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- Ised double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heat sink.
- **(1)**  $R_{\theta}$  is measured at T<sub>J</sub> of approximately 90°C.



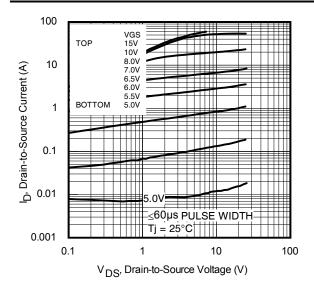


Fig. 1 Typical Output Characteristics

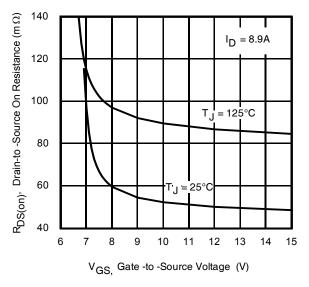


Fig. 3 Typical On-Resistance vs. Gate Voltage

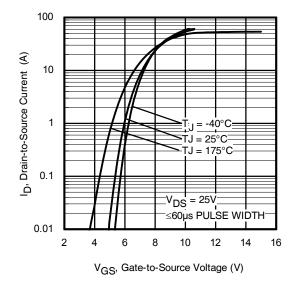
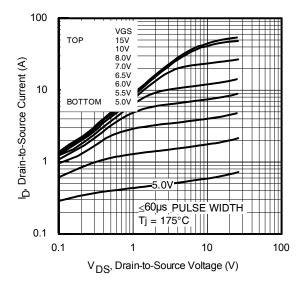
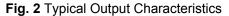


Fig 5. Transfer Characteristics

# AUIRF7665S2TR





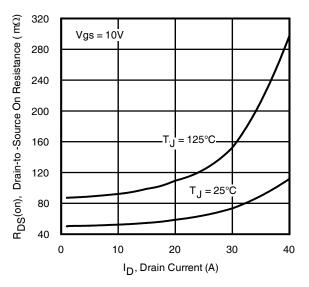


Fig. 4 Typical On-Resistance vs. Drain Current

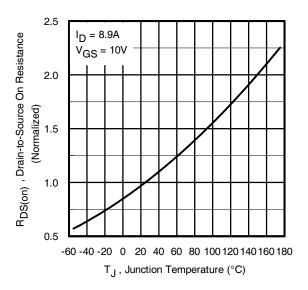


Fig 6. Normalized On-Resistance vs. Temperature



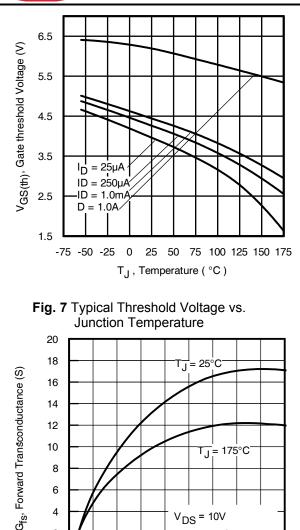


Fig 9. Typical Forward Trans conductance vs. Drain Current

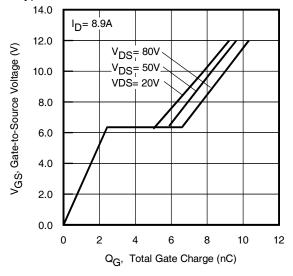
ID, Drain-to-Source Current (A)

T\_J= 175°C

380µs PULSE WIDTH

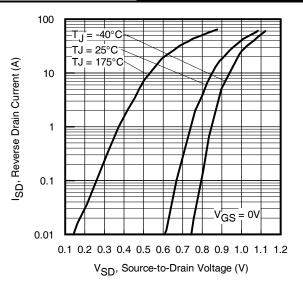
 $V_{DS} = 10V$ 

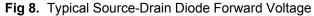
10 12 14

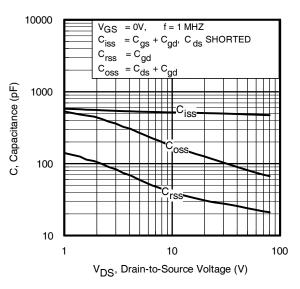


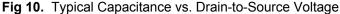


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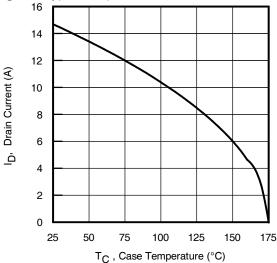
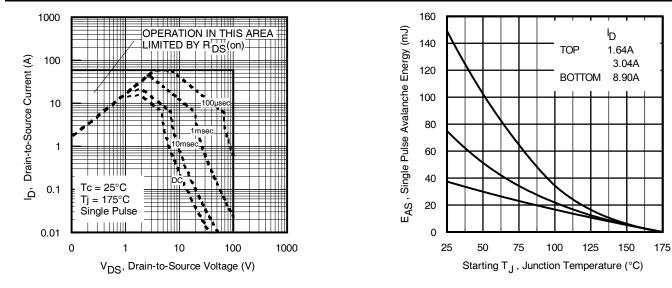


Fig 12. Maximum Drain Current vs. Case Temperature



# AUIRF7665S2TR



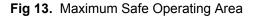


Fig 14. Maximum Avalanche Energy vs. Temperature

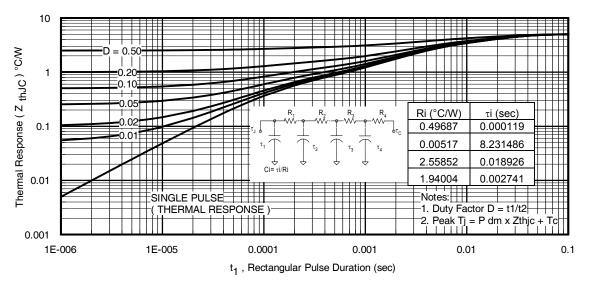
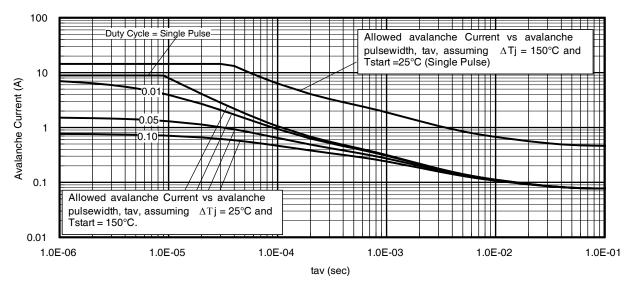
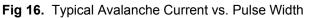
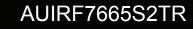


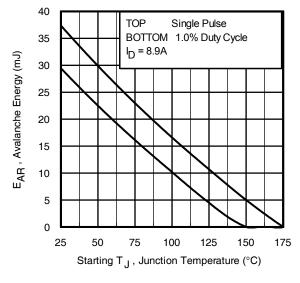
Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

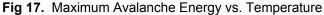












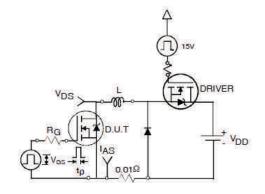


Fig 18a. Unclamped Inductive Test Circuit

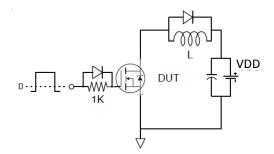


Fig 19a. Gate Charge Test Circuit

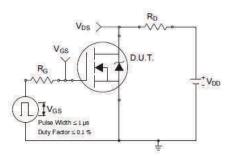


Fig 20a. Switching Time Test Circuit

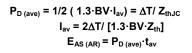
# Notes on Repetitive Avalanche Curves , Figures 16, 17:

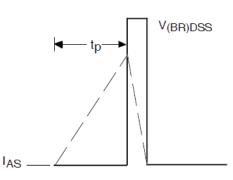
- (For further info, see AN-1005 at www.infineon.com)1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 16, 17).

tav = Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

ZthJC(D, tav) = Transient thermal resistance, see Figures 15)





#### Fig 18b. Unclamped Inductive Waveforms

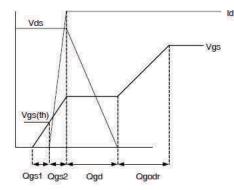


Fig 19b. Gate Charge Waveform

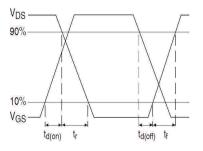
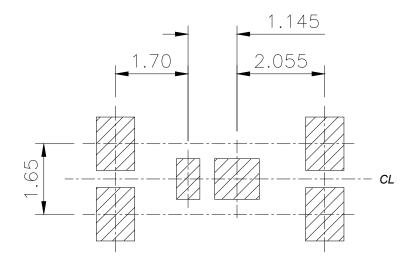


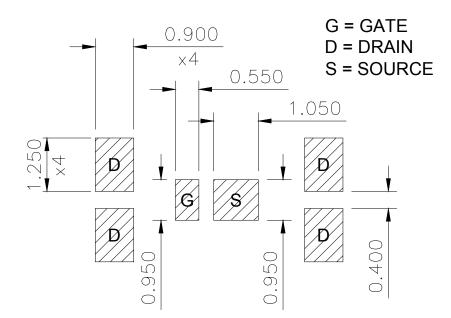
Fig 20b. Switching Time Waveforms



# DirectFET<sup>®</sup> Board Footprint, SB (Small Size Can).

Please see DirectFET<sup>®</sup> application note AN-1035 for all details regarding the assembly of DirectFET<sup>®</sup>. This includes all recommendations for stencil and substrate designs.



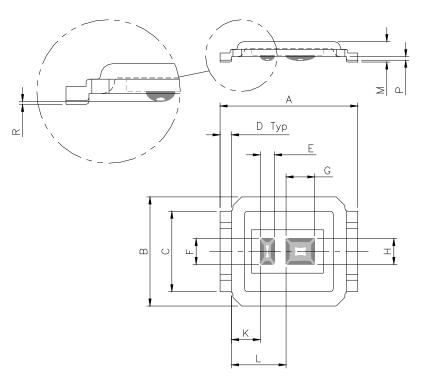


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



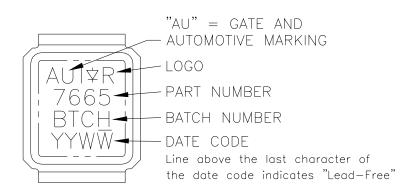
## DirectFET<sup>®</sup> Outline Dimension, SB Outline (Small Size Can).

Please see DirectFET<sup>®</sup> application note AN-1035 for all details regarding the assembly of DirectFET<sup>®</sup>. This includes all recommendations for stencil and substrate designs.



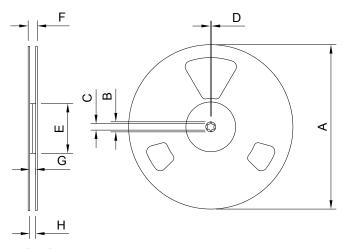
DIMENSIONS							
8							
	MET	RIC	IMPE	RIAL			
CODE	MIN	MAX	MIN	MAX			
A	4.75	4.85	0.187	0.191			
В	3.70	3.95	0.146	0.156			
С	2.75	2.85	0.108	0.112			
D	0.35	0.45	0.014	0.018			
E	0.48	0.52	0.019	0.020			
F	0.88	0.92	0.035	0.036			
G	0.98	1.02	0.039	0.040			
Н	0.88	0.92	0.035	0.036			
J	N/A	N/A	N/A	N/A			
K	0.95	1.05	0.037	0.041			
L	1.85	1.95	0.073	0.077			
M	0.68	0.74	0.027	0.029			
P	0.08	0.17	0.003	0.007			
R	0.02	0.08	0.001	0.003			

DirectFET<sup>®</sup> Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

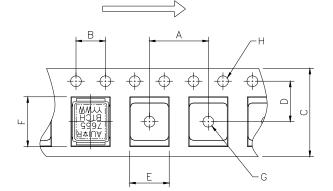
# DirectFET<sup>®</sup> Tape & Reel Dimension (Showing component orientation)



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts, ordered as AUIRF7665S2TR.

REEL DIMENSIONS						
STANDARD OPTION (QTY 4800)						
	ME	TRIC	IMP	ERIAL		
CODE	MIN	MAX	MIN	MAX		
Α	330.0	N.C	12.992	N.C		
В	20.2	N.C	0.795	N.C		
С	12.8	13.2	0.504	0.520		
D	1.5	N.C	0.059	N.C		
Е	100.0	N.C	3.937	N.C		
F	N.C	18.4	N.C	0.724		
G	12.4	14.4	0.488	0.567		
Н	11.9	15.4	0.469	0.606		

LOADED TAPE FEED DIRECTION



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS							
	MET	RIC	IMPE	RIAL			
CODE	MIN	MAX	Min	MAX			
A	7.90	8.10	0.311	0.319			
B	3.90	4.10	0.154	0.161			
С	11.90	12.30	0.469	0.484			
D	5.45	5.55	0.215	0.219			
E	4.00	4.20	0.158	0.165			
F	5.00	5.20	0.197	0.205			
G	1.50	N.C	0.059	N.C			
Н	1.50	1.60	0.059	0.063			

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

## **Qualification Information**

		Automotive				
		(per AEC-Q101)				
		Comments: This part number(s) pas	Comments: This part number(s) passed Automotive qualification. Infineon's			
		Industrial and Consumer qualification I	Industrial and Consumer qualification level is granted by extension of the higher			
		Automotive level.				
Moisture	Sensitivity Level	DFET2 Small Can	MSL1			
Machine Madal		Class B				
	Machine Model	AEC-Q101-002				
	Lives an Dady Madal	Class 2				
ESD	Human Body Model	AEC-Q101-001				
		Cla	ass IV			
	Charged Device Model	AEC-Q101-005				
RoHS Coi	mpliant	Yes				

#### **Revision History**

Date	Comments
10/5/2015	<ul> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> <li>Updated Tape and Reel option on page 10</li> </ul>

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